

Sheet 1 of 2

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)

Date Submitted to PTO: January 22, 2004

ATTY DOCKET NO.
2004-0092SERIAL NO.
NEW

101761,412

APPLICANT
Makoto IMANISHI et al.FILING DATE
January 22, 2004GROUP
1793

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
AM	AA	4,024,560	05/1977	Miller et al.			
	AB	4,518,848	05/1985	Weber			
	AC	6,544,377	04/2003	Minamitani et al.			
	AD	6,439,447	08/2002	Minamitani et al.			
	AE	6,329,640	12/2001	Narita et al.			
	AF	6,302,317	10/2001	Narita et al.			
	AG	6,506,222	01/2003	Minamitani et al.			
	AH	6,053,398	04/2000	Iizuka et al.			
AM	AI	4,846,623	07/1989	Otani et al.			

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
AM	AJ	8-78418	03/1996	JP			Abstract
	AK	7-153763	06/1995	JP			Abstract
	AL	96/41109	12/1996	WO		i	
AM	AM	09-289241	04/1997	JP			Abstract
	AN						

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

AM	AO	Patent Abstracts of Japan, vol. 1996, no. 07, July 31, 1996 (7/31/96) & JP 08 078418 A (Toshiba Corp.), March 22, 1996 (3/22/96) - English Abstract
AM	AP	N. Miyazaki et al., "Thermal shock cracking of lithium niobate single crystal", Journal of Materials Science, Materials in Electronics, Chapman & Hall, Vol. 8, No. 3, pgs 133-138 (1997).
	AQ	

EXAMINER

W. H. Liu

DATE CONSIDERED

01/22/2028

FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			ATTY DOCKET NO. 2004-0092	SERIAL NO. NEW	10/761,412		
			APPLICANT Makoto IMANISHI et al.				
Date Submitted to PTO: January 22, 2004			FILING DATE January 22, 2004		GROUP 1793		
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
AM	AA	5,430,271	07/1995	Orgami et al.			
AM	AB	5,489,192	02/1996	Taniguchi			
AM	AC	5,664,254	09/1997	Ohkura et al.			
AM	AD	5,817,178	10/1998	Mita et al.			
AM	AE	5,848,868	12/1998	Suzuki et al.			
	AF						
	AG						
	AH						
	AI						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
AM	AJ	09-050957	02/1997	JP			X
	AK						
	AL						
	AM						
	AN						
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
	AO						
	AP						
	AQ						
EXAMINER <i>W.H.W.</i>		DATE CONSIDERED 01/22/2008					

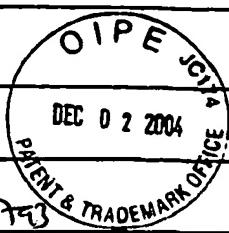
**EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.*

INFORMATION DISCLOSURE STATEMENT

FORM PTO 1449 (modified)

ATTY DOCKET NO.
2004-0092SERIAL NO.
10/761,412U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEAPPLICANT
Makoto IMANISHI et al.LIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)

Date Submitted to PTO: December 2, 2004

FILING DATE
January 22, 2004

U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
AM	AJ	6-232132	8/1994	JP			Partial
AM	AK	64-12555	1/1989	JP			Partial
	AL						
	AM						
	AN						
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
	AO						
	AP						
	AQ						
EXAMINER		<i>Whe</i>		DATE CONSIDERED		01/22/2008	

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Sheet 1 of 1

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10/761,412U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)

Date Submitted to PTO: May 27, 2004

APPLICANT
Makoto IMANISHI et al.FILING DATE
January 22, 2004GROUP
1725

MAY 27 2006



U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
ATM	AA	6,568,580	05/2003	Narita et al.			
ATM	AB	6,494,358	12/2002	Narita et al.			
ATM	AC	6,349,447	02/2002	Zimmer			
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AJ						
	AK						
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	AM						
	AN						

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

	AO	
	AP	
	AQ	

EXAMINER

W. Hu

DATE CONSIDERED

01/22/2008

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